# VE320 Intro to Semiconductor Devices Summer 2022 — Problem Set 6

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#### Constants

[Note: In the following problems, assume  $T=300~\mathrm{K}$  and the following parameters unless otherwise stated. For silicon pn junctions:  $D_n=25~\mathrm{cm^2/s}, D_p=10~\mathrm{cm^2/s}, \tau_{n0}=5\times10^{-7}~\mathrm{s}, \tau_{p0}=10^{-7}~\mathrm{s}$ . For GaAs pn junctions:  $D_n=205~\mathrm{cm^2/s}, D_p=9.8~\mathrm{cm^2/s}, \tau_{n0}=5\times10^{-8}~\mathrm{s}, \tau_{p0}=10^{-8}~\mathrm{s}$ .]

#### Exercise 6.1

- (a) Consider an ideal pn junction diode at  $T=300~\mathrm{K}$  operating in the forward-bias region. Calculate the change in diode voltage that will cause a factor of 10 increase in current.
  - (b) Repeat part (a) for a factor of 100 increase in current.

### Exercise 6.2

Consider a GaAs pn junction diode at T=300 K. The parameters of the device are  $N_d=2\times 10^{16}$  cm<sup>-3</sup>,  $N_a=8\times 10^{15}$  cm<sup>-3</sup>,  $D_n=210$  cm<sup>2</sup>/s,  $D_p=8$  cm<sup>2</sup>/s,  $\tau_{no}=10^{-7}$  s, and  $\tau_{po}=5\times 10^{-8}$  s. Determine the ideal reverse-saturation current density.

## Exercise 6.3

Consider an ideal silicon pn junction diode.

- (a) What must be the ratio of  $N_d/N_a$  so that 90 percent of the current in the depletion region is due to the flow of electrons?
- (b) Repeat part (a) if 80 percent of the current in the depletion region is due to the flow of holes.

#### Exercise 6.4

Consider a silicon pn junction diode with an applied reverse-biased voltage of  $V_R=5$  V. The doping concentrations are  $N_a=N_d=4\times 10^{16}$  cm<sup>-3</sup> and the cross-sectional area is  $A=10^{-4}$  cm<sup>2</sup>. Assume minority carrier lifetimes of  $\tau_0=\tau_{n0}=\tau_{p0}=10^{-7}$  s. Calculate the

- (a) ideal reverse-saturation current
- (b) reverse-biased generation current
- (c) the ratio of the generation current to ideal saturation current.

## Exercise 6.5

Consider, as shown in Figure, a uniformly doped silicon pn junction at T=300 K with impurity doping concentrations of  $N_a=N_d=5\times 10^{15}$  cm<sup>-3</sup> and minority carrier lifetimes of  $\tau_{n0}=\tau_{p0}=\tau_0=10^{-7}$  s. A reverse-biased voltage of  $V_R=10$  V is applied. A light source is incident only on the space charge region, producing an excess carrier generation rate of  $g'=4\times 10^{19}$  cm<sup>-3</sup> s<sup>-1</sup>. Calculate the generation current density.

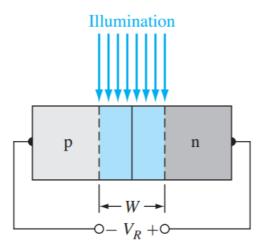


Figure 1: Figure for Problem 6.5

## Exercise 6.6

A silicon pn junction at  $T=300~\mathrm{K}$  is reverse biased at  $V_\mathrm{R}=8~\mathrm{V}$ . The doping concentrations are  $N_\mathrm{a}=5\times10^{16}~\mathrm{cm^{-3}}$  and  $N_\mathrm{d}=5\times10^{15}~\mathrm{cm^{-3}}$ . Draw the band diagram of the pn junction, and determine  $x_\mathrm{n},x_\mathrm{p},W,$  and  $|E_\mathrm{max}|$ . Please provide the process of derivation.

### Exercise 6.7

- (a) Sketch the energy bands in a zero-biased, reverse-biased, and forward-biased pn junction.
- (b) Sketch the steady-state minority carrier concentrations in a forward-biased pn junction.
- (c) Sketch the forward-bias I–V characteristics of a pn junction diode showing the effects of recombination and high-level injection.

# Reference

1. Neamen, Donald A. Semiconductor physics and devices: basic principles. McGrawhill, 2003.